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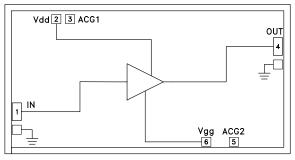
HMC460

Typical Applications

The HMC460 is ideal for:

- Telecom Infrastructure
- Microwave Radio & VSAT
- Military & Space
- Test Instrumentation

Functional Diagram



GaAs pHEMT MMIC LOW NOISE AMPLIFIER, DC - 20 GHz

Features

Noise Figure: 2.5 dB @ 10 GHz Gain: 14 dB @ 10 GHz P1dB Output Power: +16 dBm @ 10 GHz Supply Voltage: +8V @ 60 mA 50 Ohm Matched Input/Output Die Size: 3.12 x 1.63 x 0.1 mm

General Description

The HMC460 is a GaAs MMIC PHEMT Low Noise Distributed Amplifier die which operates between DC and 20 GHz. The amplifier provides 14 dB of gain, 2.5 dB noise figure and +16 dBm of output power at 1 dB gain compression while requiring only 60 mA from a +8V supply. The HMC460 amplifier can easily be integrated into Multi-Chip-Modules (MCMs) due to its small size. All data is with the chip in a 50 Ohm test fixture connected via 0.025mm (1 mil) diameter wire bonds of minimal length 0.31mm (12 mils).

Electrical Specifications, $T_{A} = +25^{\circ}$ C, Vdd= 8V, Idd= 60 mA*

| Parameter | Min. | Тур. | Max. | Min. | Тур. | Max. | Min. | Тур. | Max. | Units |
|---|----------|-------|------------|------|-------------|------|------|--------|------|--------|
| Frequency Range | DC - 6.0 | | 6.0 - 18.0 | | 18.0 - 20.0 | | | GHz | | |
| Gain | 12 | 14 | | 12 | 14 | | 11 | 13 | | dB |
| Gain Flatness | | ± 0.5 | | | ± 0.15 | | | ± 0.25 | | dB |
| Gain Variation Over Temperature | | 0.008 | 0.016 | | 0.01 | 0.02 | | 0.01 | 0.02 | dB/ °C |
| Noise Figure | | 4.0 | 5.0 | | 2.5 | 3.5 | | 3.0 | 4.0 | dB |
| Input Return Loss | | 17 | | | 22 | | | 15 | | dB |
| Output Return Loss | | 17 | | | 15 | | | 15 | | dB |
| Output Power for 1 dB Compression (P1dB) | 14 | 17 | | 13 | 16 | | 12 | 15 | | dBm |
| Saturated Output Power (Psat) | | 18 | | | 18 | | | 17 | | dBm |
| Output Third Order Intercept (IP3) | | 27.5 | | | 28 | | | 27 | | dBm |
| Supply Current (Idd) (Vdd= 8V, Vgg1= -0.9V Typ.) | | 60 | | | 60 | | | 60 | | mA |

* Adjust Vgg between -2 to 0V to achieve Idd= 60 mA typical.

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HMC460* PRODUCT PAGE QUICK LINKS

Last Content Update: 02/23/2017

COMPARABLE PARTS

View a parametric search of comparable parts.

EVALUATION KITS

• HMC460LC5 Evaluation Board

DOCUMENTATION

Application Notes

- Broadband Biasing of Amplifiers General Application Note
- MMIC Amplifier Biasing Procedure Application Note
- Thermal Management for Surface Mount Components General Application Note

Data Sheet

• HMC460 Die Data Sheet

TOOLS AND SIMULATIONS \square

- HMC460 Die S-Parameters
- HMC460LC5 S-Parameters

REFERENCE MATERIALS

Quality Documentation

- Package/Assembly Qualification Test Report: LC5, LC5A (QTR: 2014-00384 REV: 01)
- Semiconductor Qualification Test Report: PHEMT-F (QTR: 2013-00269)

DESIGN RESOURCES

- HMC460 Material Declaration
- PCN-PDN Information
- Quality And Reliability
- Symbols and Footprints

DISCUSSIONS

View all HMC460 EngineerZone Discussions.

SAMPLE AND BUY

Visit the product page to see pricing options.

TECHNICAL SUPPORT

Submit a technical question or find your regional support number.

DOCUMENT FEEDBACK

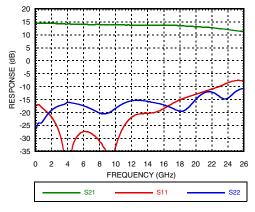
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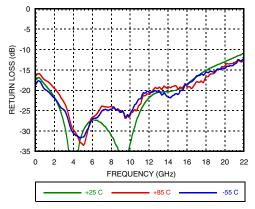
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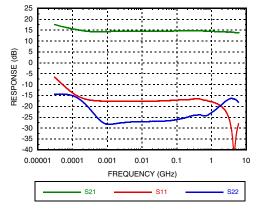
Broadband Gain & Return Loss



Input Return Loss vs. Temperature

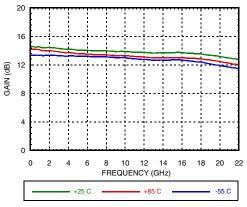


Low Frequency Gain & Return Loss

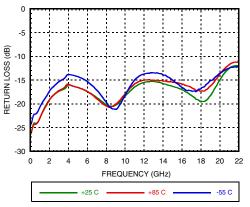


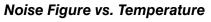


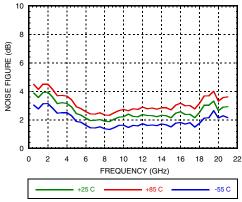




Output Return Loss vs. Temperature







AMPLIFIERS - LOW NOISE - CHIP

2

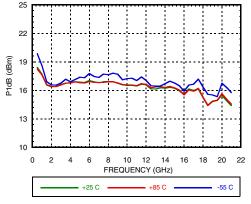
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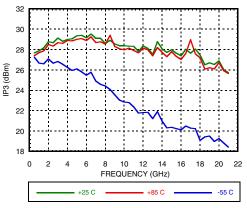


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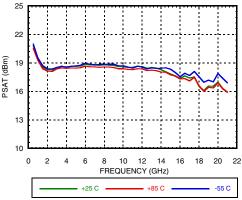
Output P1dB vs. Temperature



Output IP3 vs. Temperature



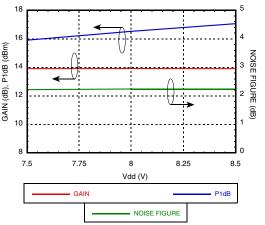
Psat vs. Temperature



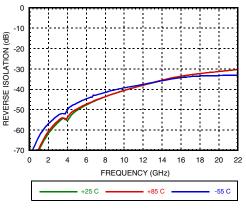
GaAs pHEMT MMIC LOW NOISE

AMPLIFIER, DC - 20 GHz

Gain, Power & Noise Figure vs. Supply Voltage @ 10 GHz, Fixed Vgg1



Reverse Isolation vs. Temperature



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Absolute Maximum Ratings

| | 5 |
|---|----------------|
| Drain Bias Voltage (Vdd) | +9 Vdc |
| Gate Bias Voltage (Vgg) | -2 to 0 Vdc |
| Gate Bias Voltage (Igg) | 2.5 mA |
| RF Input Power (RFIN)(Vdd = +8 Vdc) | +18 dBm |
| Channel Temperature | 175 °C |
| Continuous Pdiss (T = 85 °C) (derate 24 mW/°C above 85 °C) | 2.17 W |
| Thermal Resistance (channel to die bottom) | 41.5 °C/W |
| Storage Temperature | -65 to +150 °C |
| Operating Temperature | -55 to +85 °C |

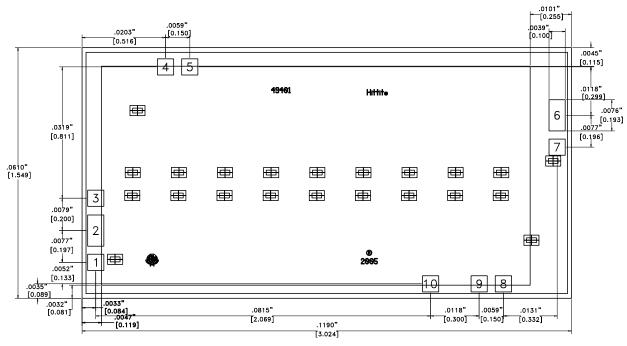
GaAs pHEMT MMIC LOW NOISE AMPLIFIER, DC - 20 GHz

Typical Supply Current vs. Vdd

| Vdd (V) | | ldd (mA) | | |
|---------|------|----------|--|--|
| | +7.5 | 59 | | |
| | +8.0 | 60 | | |
| | +8.5 | 62 | | |



Outline Drawing



Die Packaging Information [1]

| Standard | Alternate |
|-----------------|-----------|
| GP-1 (Gel Pack) | [2] |

[1] Refer to the "Packaging Information" section for die packaging dimensions.

[2] For alternate packaging information contact Hittite Microwave Corporation.

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NOTES:

- 1. ALL DIMENSIONS IN INCHES [MILLIMETERS]
- 2. NO CONNECTION REQUIRED FOR UNLABELED BOND PADS
- 3. DIE THICKNESS IS 0.004 (0.100)
- 4. TYPICAL BOND PAD IS 0.004 (0.100) SQUARE
- 5. BACKSIDE METALLIZATION: GOLD
- 6. BACKSIDE METAL IS GROUND
- 7. BOND PAD METALIZATION: GOLD



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GaAs pHEMT MMIC LOW NOISE AMPLIFIER, DC - 20 GHz

Pad Descriptions

| Pad Number | Function | Description | Interface Schematic |
|---------------|----------|--|---------------------|
| 1 | RFIN | This pad is DC coupled and matched to 50 Ohms. | |
| 2 | Vdd | Power supply voltage for the amplifier. External bypass capacitors are required | OVdd |
| 3 | ACG1 | Low frequency termination. Attach bypass capacitor per application circuit herein. | ACG1 RFOUT |
| 4 | RFOUT | This pad is DC coupled and matched to 50 Ohms. | |
| 5 | ACG2 | Low frequency termination. Attach bypass capacitor per application circuit herein. | |
| 6 | Vgg | Gate control for amplifier. Adjust to achieve Idd= 60 mA. | Vgg O |
| Die Bottom | GND | Die bottom must be connected to RF/DC ground. | |

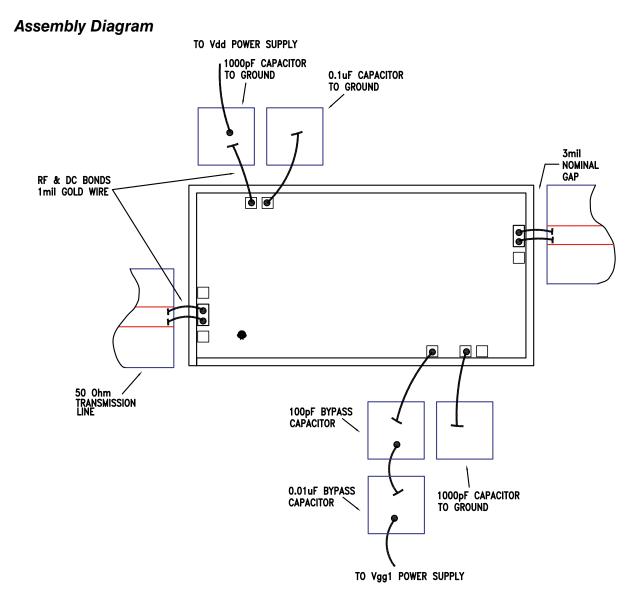
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Mounting & Bonding Techniques for Millimeterwave GaAs MMICs

The die should be attached directly to the ground plane eutectically or with conductive epoxy (see HMC general Handling, Mounting, Bonding Note).

50 Ohm Microstrip transmission lines on 0.127mm (5 mil) thick alumina thin film substrates are recommended for bringing RF to and from the chip (Figure 1). If 0.254mm (10 mil) thick alumina thin film substrates must be used, the die should be raised 0.150mm (6 mils) so that the surface of the die is coplanar with the surface of the substrate. One way to accomplish this is to attach the 0.102mm (4 mil) thick die to a 0.150mm (6 mil) thick molybdenum heat spreader (moly-tab) which is then attached to the ground plane (Figure 2).

Microstrip substrates should be located as close to the die as possible in order to minimize bond wire length. Typical die-to-substrate spacing is 0.076mm to 0.152 mm (3 to 6 mils).

Handling Precautions

Follow these precautions to avoid permanent damage.

Storage: All bare die are placed in either Waffle or Gel based ESD protective containers, and then sealed in an ESD protective bag for shipment. Once the sealed ESD protective bag has been opened, all die should be stored in a dry nitrogen environment.

Cleanliness: Handle the chips in a clean environment. DO NOT attempt to clean the chip using liquid cleaning systems.

Static Sensitivity: Follow ESD precautions to protect against $> \pm 250V$ ESD strikes.

Transients: Suppress instrument and bias supply transients while bias is applied. Use shielded signal and bias cables to minimize inductive pick-up.

General Handling: Handle the chip along the edges with a vacuum collet

or with a sharp pair of bent tweezers. The surface of the chip may have fragile air bridges and should not be touched with vacuum collet, tweezers, or fingers.

Mounting

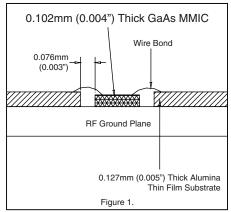
The chip is back-metallized and can be die mounted with AuSn eutectic preforms or with electrically conductive epoxy. The mounting surface should be clean and flat.

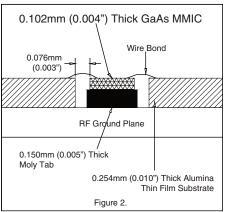
Eutectic Die Attach: A 80/20 gold tin preform is recommended with a work surface temperature of 255 °C and a tool temperature of 265 °C. When hot 90/10 nitrogen/hydrogen gas is applied, tool tip temperature should be 290 °C. DO NOT expose the chip to a temperature greater than 320 °C for more than 20 seconds. No more than 3 seconds of scrubbing should be required for attachment.

Epoxy Die Attach: Apply a minimum amount of epoxy to the mounting surface so that a thin epoxy fillet is observed around the perimeter of the chip once it is placed into position. Cure epoxy per the manufacturer's schedule.

Wire Bonding

Ball or wedge bond with 0.025mm (1 mil) diameter pure gold wire. Thermosonic wirebonding with a nominal stage temperature of 150 °C and a ball bonding force of 40 to 50 grams or wedge bonding force of 18 to 22 grams is recommended. Use the minimum level of ultrasonic energy to achieve reliable wirebonds. Wirebonds should be started on the chip and terminated on the package or substrate. All bonds should be as short as possible <0.31mm (12 mils).







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Notes:

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